PATENT

### Plactitioner's Docket No. 1012-108D1(2000-098DIV1)

#### IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Serial No.: Unknown

Group Art Unit: Unknown Examiner: Unknown

Serial No.: Unkno Filed: Herewith

For: HIGH THROUGHPUT MECHANICALRAPID SERIAL PROPERTY TESTING

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Applicants submit this statement in accordance with their duty of disclosure under 37 CFR 1.56 and 1.97-1.98. The submission made herewith is in no way intended as an admission that the cited items constitute material prior art or otherwise would render the claims unpatentable in any way. The submission also is in no way intended to substitute for the Examiner's own independent investigation.

A listing of the references on forms PTO/SB/08A and PTO/SB/08B are submitted herewith. Copies of the references have not been provided due to their presence in the parent application except Chuang, which is newly cited. Applicants respectfully solicit the Examiner's consideration of the cited references and entry thereof into the record of this application.

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Sheet 3 of 3

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Application Number	09/939,252	
Filing Date	08/24/2001	
First Named Inventor	Paul Mansky	
Group Art Unit	1754	
Examiner Name		
Attorney Docket Number	1012-108(2000-089)	

				U.S. PATENT DOC	UMENTS	
Examiner Initials*	Cite No.1	U.S. Patent I Number	Cocument  Kind Code <sup>2</sup> (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		5,481,153		Turner	01/02/1996	
		5,610,325		Rajagopal et al.	03/11/1997	
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Initials* No.	No. <sup>1</sup>	Office <sup>3</sup>	Number <sup>4</sup>	(if known)	Applicant of Cited Document	MM-DD-YYYY	Passages or Relevant Figures Appear	T <sup>6</sup>
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		5,776,359		Schultz et al.	07/07/1998	
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			WO 00/67086		Symyx Technologies, Inc.	11/09/2000		
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Filing Date	08/24/2001
First Named Inventor	Paul Mansky
Group Art Unit	1754
Examiner Name	
Attorney Docket Number	1012-108(2000-089)

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		6,242,623	B1	Boussie et al.	06/05/2001	
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**U.S. PATENT DOCUMENTS** Pages, Columns, Lines, U.S. Patent Document Date of Publication of Name of Patentee or Applicant Cite Examine Where Relevant Cited Document Kind Code<sup>2</sup> Passages or Relevant of Cited Document Number MM-DD-YYYY (if known) Figures Appear 10/06/1<del>99</del>8 5.817.947 Bergerus ,723,792 03/03/1998 Miyazaki 5,532,942 Kitamura et al. 07/02/1996 5,520,042 05/28/1996 Garritano et al 5,517,860 Lin et al. 05/21/1996 5,452,614 09/26/1995 Kato et al. 5,438,863 Johnson 08/08/1995 08/01/1995 5,437,192 Kawamoto et al 398,885 03/21/1995 Andersson et al 12/14/1993 5,269,190 Kramer et al. 03/03/1992 5,092,179 Ferguson 4,899,581 Allen et al 02/13/1990 4,715,007 12/22/1987 Fuiita et al. 4,699,000 Lashmore et al 10/13/1987 08/12/1986 4,605,589 **Orphanides** 4,975,320 Goldstein et al. 12/04/1990 6,043,317Mumick et al. 03/28/2000

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Examiner	Cite	F	oreign Patent Doc		Name of Patentee or	Date of Publication of	Pages, Columns, Lines, Where Relevant	
Initials*	No.1	Office <sup>3</sup>	Number <sup>4</sup>	Kind Code <sup>5</sup> (if known)	Applicant of Cited Document	Cited Document MM-DD-YYYY	Passages or Relevant Figures Appear	T <sup>6</sup>
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0000	outdio for form 1440/01 10			Application Number	09/939.252	
IN	FORMATION D	ISCLO	SURE	Filing Date	08/24/2001	W.d
	TATEMENT BY			First Named Inventor	Mansky	
	IAILMENT DI	/ (1 1 641	<b>0</b> 7 (11)	Art Unit	2855	
	(Use as many sheets a	s necessary)		Examiner Name	Mack	
Sheet	1	of	1	Attorney Docket Number	1012-108	

			U. S. PATENT	DOCUMENTS	
Examiner Initials*	Cite No. <sup>1</sup>	Document Number  Number-Kind Code <sup>2 (if known)</sup>	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		<sup>US-</sup> 02/0194930	12/26/2002	Crosby et al.	
		US-			
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Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document  Country Code <sup>3–</sup> Number <sup>4–</sup> Kind Code <sup>5</sup> ( <i>if known</i> )	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Τ <sup>6</sup>			
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Group Art Unit 1754

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		3,071,961		Heigl et al.	01/08/1963				
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Attorney Docket Number

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Examiner Initials*	No.1	Office <sup>3</sup>	Number <sup>4</sup>	Kind Code <sup>5</sup> (if known)	Applicant of Cited Document	Cited Document MM-DD-YYYY	Passages or Relevant Figures Appear	T <sup>6</sup>					
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<sup>1</sup> Unique citation designation number. 2 See attached Kinds of U.S. Patent Documents. 3 Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). 4 For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the senal number of the patent document. 5 Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached.

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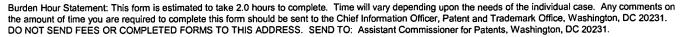
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Substitu	ute for form 1449B/PTO		Со	mplete if Known
			Application Number	09/939,252
INF	ORMATION	DISCLOSURE	Filing Date	08/24/2001
STA	TEMENT B	Y APPLICANT	First Named Inventor	Paul Manksy
017	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	. /	Group Art Unit	1754
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Sheet	1	of O	Attorney Docket Number	1012-108(2000-089)

		OTHER PRIOR ART NON PATENT LITERATURE DOCUMENTS	
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		*U.S. Application Serial No. 09/420,334 entitled " Graphic Design of Combinatorial Material Libraries" (Lacy, et al.) filed on October 18, 1999	
		*U.S. Patent Application Serial No. 09/305,830 titled "Synthesizing Combinatorial Libraries of Materials" (Rust, et al.) filed on May 5, 1999	
_		*U.S. Application Serial No. 09/550,549 entitled "Automated Process Control And Data Management System And Methods" (Crevier, et al.) filed on April 14, 2000	
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		*The family of applications for U.S. Application Serial No. 09/227,558 entitled, "Apparatus and Method of Research for Creating and Testing Novel Catalysts, Reactions and Polymers" (Turner et al.) filed January 8, 1999	
		*The family of applications for U.S. Application Serial No. 09/211,982 entitled "Parallel Reactor With Internal Sensing" (Turner et al.) filed December 14, 1998	
		*U.S. Application Serial No. 09/235,368 entitled "Polymerization Method From the Combinatorial Synthesis and Analysis of Organometallic Compounds and Catalysts" (Weinberg et al.) filed on January 21, 1999	
		*U.S. Provisional Application Serial No. 60/122,704 entitled "Controlled, Stable Free Radical Emulsion and Water-Based Polymerizations" (Klaerner et al.) filed on March 9, 1999	
		The family of applications for U.S. Application Serial No. 09/156,827 entitled "Formation of Combinatorial Arrays of Materials Using Solution-Based Methodologies" (Giaquinta et al.) filed September 18, 1998	
		*The family of applications for U.S. Application Serial No. 09/567,598 entitled "Polymer Libraries on a Substrate, Method for Forming Polymer Libraries on a Substrate and Characterization Methods with Same" (Boussie et al.) filed May 10, 2000	
		U.S. Application Serial No. 09/579,338 entitled "Rheo-Optical Indexer and Method of Screening and Characterizing Arrays of Materials" (Carlson et al.) filed on May 25, 2000	

Examiner	Date
Signature	Considered

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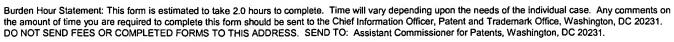
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INF	ORMATION	DISCLOSURE	Filing Date	08/24/2001			
STA	TEMENT F	BY APPLICANT	First Named Inventor	Paul Manksy			
017	E.W. E.W.		Group Art Unit	1754			
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		*ODIAN, Principles of Polymerization, 3rd Ed., John Wiley & Sons, Inc. (1991)				
		YOUNG, W.C., Roark's Formulas for Stress and Stain, 1989				
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		RAEEL, MASTURA and Jiang Liu, "An Empirical Model for Fabric Hand" Textile Research Journal 62, 1, pp. 31-38 (1991).				
		ALI, S.I. and Shahida Begum, "Fabric Softeners and Softness Perception", Ergonomics, v.37, No. 5, pp. 801-806 (1994).				
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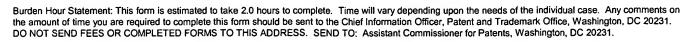
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			Application Number	09/939,252	
INF	ORMATION	DISCLOSURE	Filing Date	08/24/2001	
STA	ATEMENT I	BY APPLICANT	First Named Inventor	Paul Manksy	
017		DI ALI LIÇANI	Group Art Unit	1754	
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		U.S. Patent Application Serial No. 09/939,404 entitled "High Throughput Mechanical Property and Bulge Testing of Material Libraries," (D. Hajduk et al.) filed on August 24, 2001.			
		U.S. Patent Application Serial No. 09/939,139 entitled "High Throughput Fabric Handle Screening," (M. Kossuth et al.) filed on August 24, 2001.			
		U.S. Patent Application Serial No. 09/939,149 entitled "High Throughput Rheological Testing of Materials," (P. Mansky et al.) filed on August 24, 2001.			
		U.S. Patent Application Serial No. 09/939,263 entitled "High Throughput Mechanical Property Testing of Materials Libraries Using Capacitance," (D. Hajduk et al.) filed on August 24, 2001.			
		U.S. Patent Application Serial No. 09/938,994 entitled "High Throughput Mechanical Property Testing of Materials Libraries Using a Piezoelectric," (D. Hajduk) filed on August 24, 2001.			
		The family of applications for U.S. Patent Application Serial No. 09/580,024 entitled "Instrument for High Throughput Measurement of Material Physical Properties and Method of Using Same," (Carlson, et al.) filed on May 26, 2000			
		*The family of applications for U.S. Patent Application Serial No. 09/174,856 titled "Graphic Design of Combinatorial Material Libraries" (Lacy, et al.) filed on October 19, 1998.			
		U.S. Application Serial No. 09/801,165 entitled "Method and Apparatus for Characterizing Materials By Using a Mechanical Resonator" filed March 7, 2001			
		U.S. Application Serial No. 09/578,997 entitled "High Throughput Viscometer and Method of Using Same" filed May 25, 2000			
		*PCT Application No. PCT/US01/11417 entitled "Automated Process Control And Data Management System And Methods", filed 4/6/2001			

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Signature	Considered

<sup>&</sup>lt;sup>1</sup> Unique citation designation number. <sup>2</sup> Applicant is to place a check mark here if English language Translation is attached.



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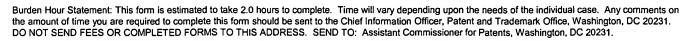
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			Application Number	09/939,252	
INF	ORMATION	DISCLOSURE	Filing Date	08/24/2001	
STA	ATEMENT R	Y APPLICANT	First Named Inventor	Paul Mansky	
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		OTHER PRIOR ART NON PATENT LITERATURE DOCUMENTS	
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		The family of applications for U.S. Patent Application Serial No. 09/174,856 titled "Graphic Design of Combinatorial Material Libraries" (Lacy, et al.) filed on October 19, 1998.	
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<sup>&</sup>lt;sup>1</sup> Unique citation designation number. <sup>2</sup> Applicant is to place a check mark here if English language Translation is attached.



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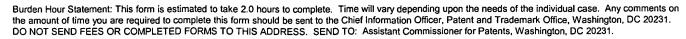
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Substitu	Substitute for form 1449B/PTO		Complete if Known		
			Application Number	09/939,252	
INF	INFORMATION DISCLOSURE		Filing Date	08/24/2001	
STA	TEMENT I	BY APPLICANT	First Named Inventor	Paul Mansky	
017		SI AII EIG/III	Group Art Unit	1754	
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Sheet	1	of 0	Attorney Docket Number	1012-108(2000-089)	

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		"DMA 2980 Dynamic Mechanical Analyer," http://www.tainst.com/dma2.html, 12/29/00	L			
		"Introducing the NEW DMTA V!", http://www.rheometricscientific.com/dmtaV.htm, 12/29/00				
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